Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/602,642	SHIMIZU ET AL.	
Examiner	Art Unit	
Madeleine AV Nouven	2626	

SEARCHED				
Class	Subclass	Date	Examiner	
update		3/23/2006	AV	
	:			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	3/23/2006	AV	